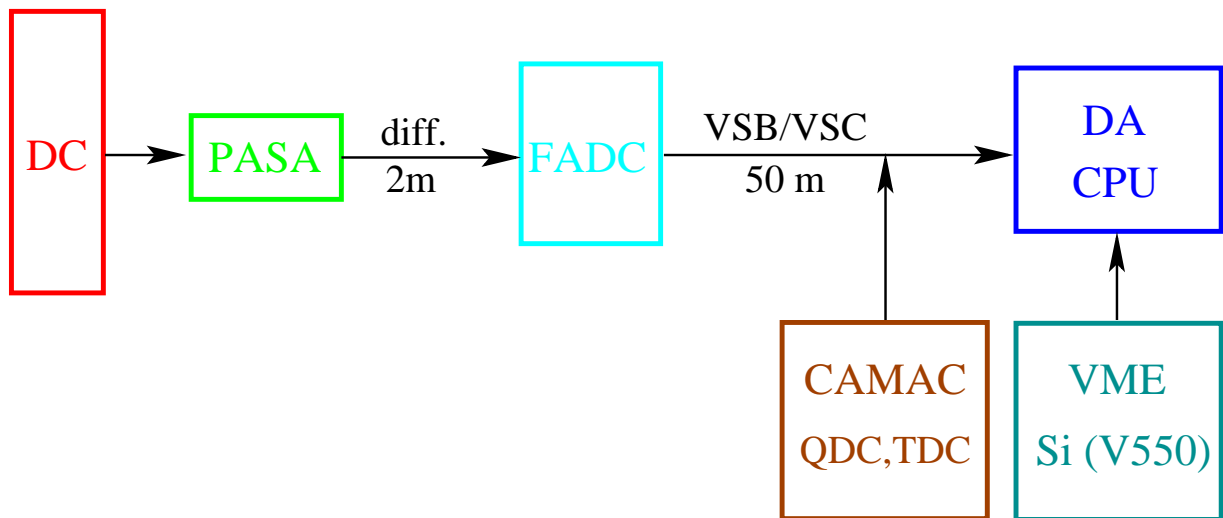
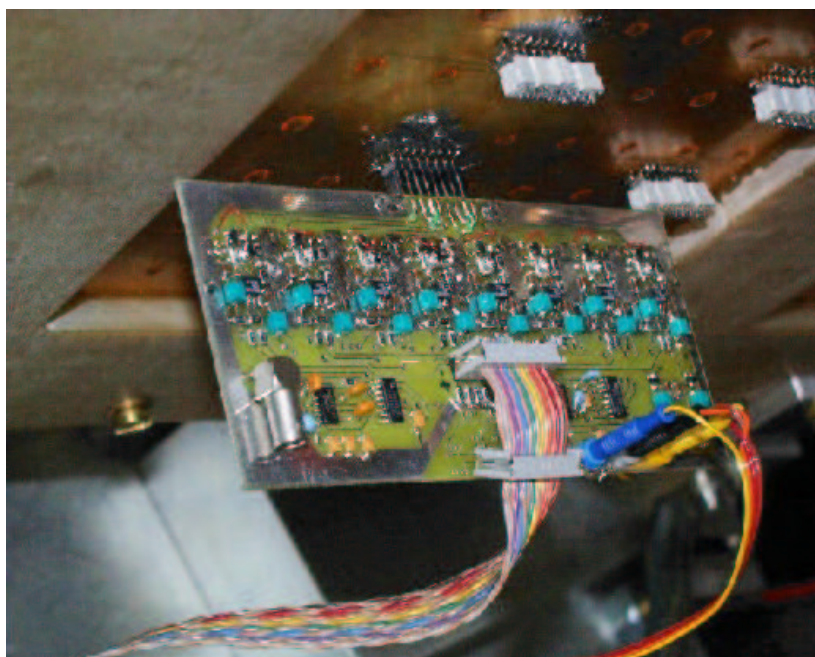


TRD tests – Electronics and DA



- **DC** – Drift chamber
- **PASA** – Preamplifier/Shaper: 2 mV/fC, 1800 e rms, 100 ns FWHM
- **FADC** – Flash-ADC (Struck), 100 MHz, 8 bit non-lin., 0.6 mV
- **DA-CPU** – VME (E7, RIO2), LynxOS, MBS DA (GSI standard)



current sensitive PA